## Applicant(s)/Patent Under Application/Control No. Reexamination 10/602,818 NAGPAL ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 Mark Kopec 1751 **U.S. PATENT DOCUMENTS** Document Number Date Classification Name Country Code-Number-Kind Code MM-YYYY \* US-2004/0233526 11-2004 Kaminsky et al. 359/452 Α \* US-2003/0175004 09-2003 Garito et al. 385/143 В С US-US-D US-Ε US-F US-G US-Н US-US-J US-Κ US-US-М FOREIGN PATENT DOCUMENTS **Document Number** Date Country Name Classification Country Code-Number-Kind Code MM-YYYY N 0 Р Q R S Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)

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